

Electronics for Information Technology (IELe)

2nd lab

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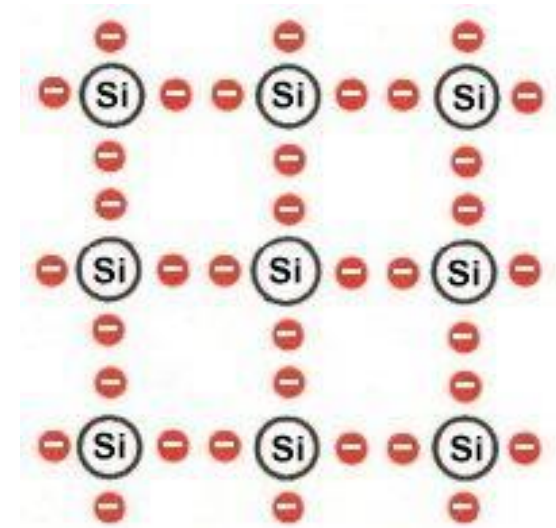


2017/2018

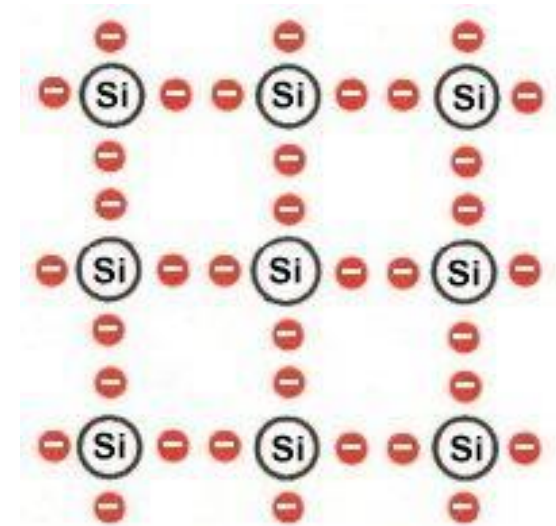
- **Diode**
 - Basics
 - **V-A characteristic**
 - **Logical addition in diode logic**

SEMICONDUCTOR DIODE

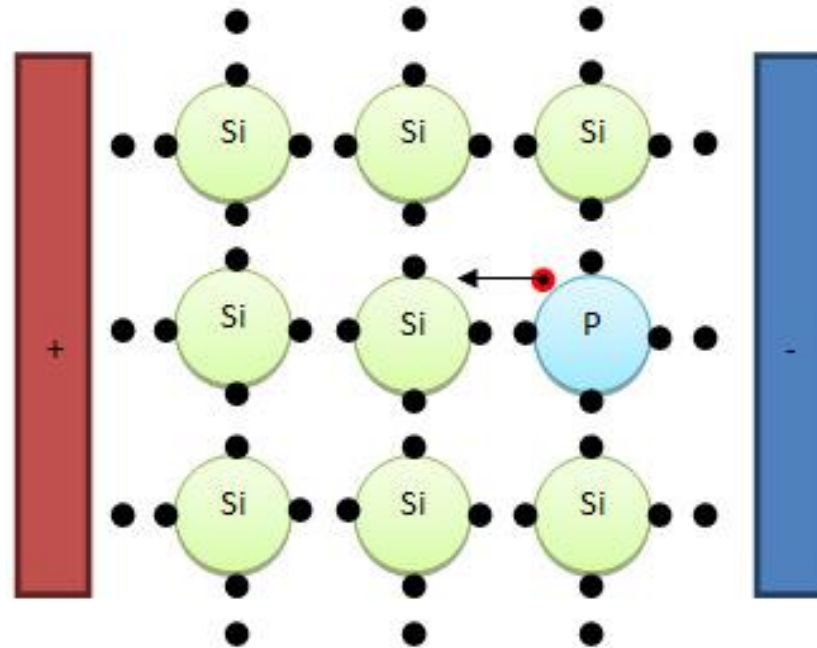
- Intrinsic and doped (extrinsic)
- **Intrinsic**
 - Silicon (Si)
 - Valence layer – 4 electrons, electrically neutral
 - By doping, neutrality is lost → 2 types of semiconductors



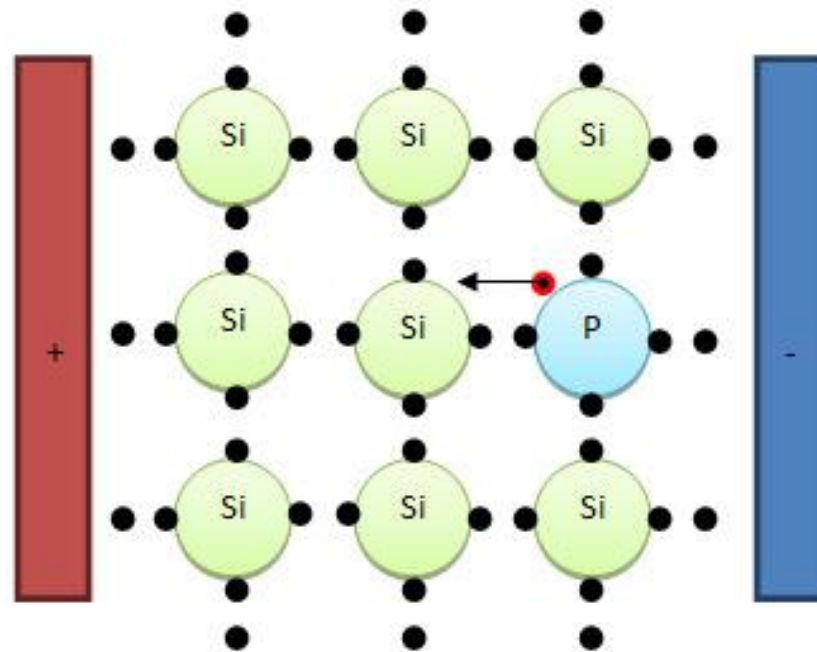
- Intrinsic and doped (extrinsic)
- **Intrinsic**
 - Silicon (Si)
 - Valence layer – 4 electrons, electrically neutral
 - By doping, neutrality is lost → 2 types of semiconductors
- **Doped (extrinsic)**
 - N type semiconductors
 - P type semiconductors



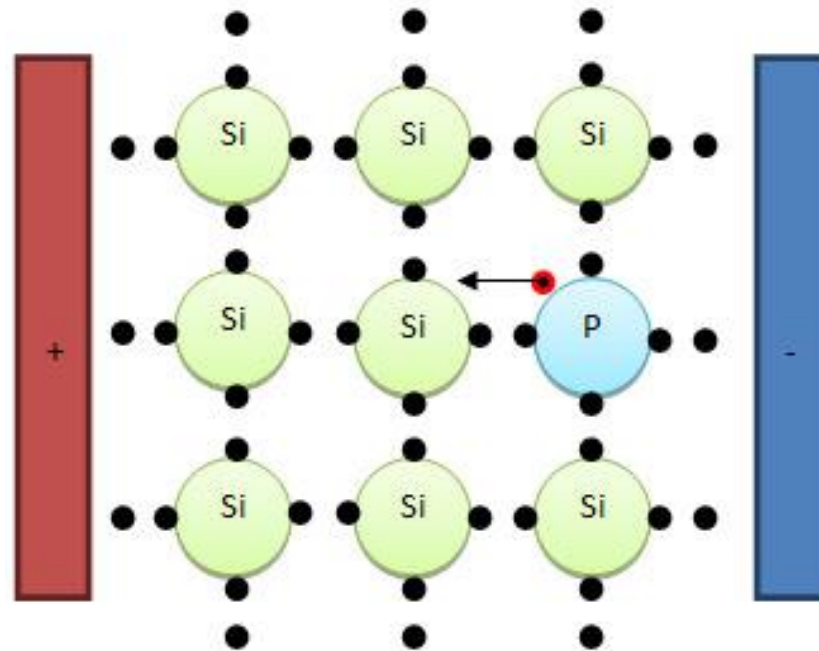
- **Type N:** electron conductivity, dopand has +1 electron
 - **Example:** phosphorus (P) – 5 electrons in the valence layer



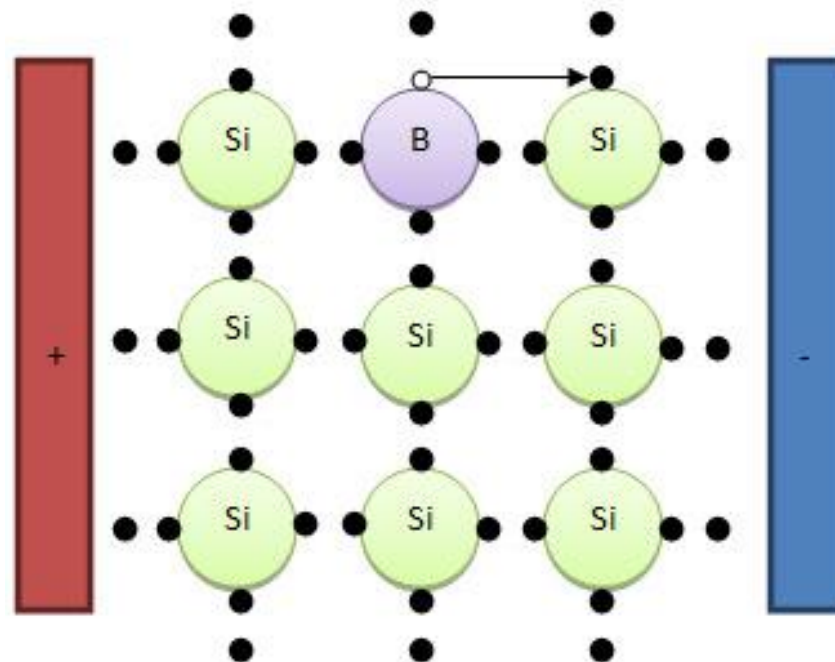
- **Type N:** electron conductivity, dopand has +1 electron
 - **Example:** phosphorus (P) – 5 electrons in the valence layer
 - Phosphorus adds 1 free electron into the crystal structure



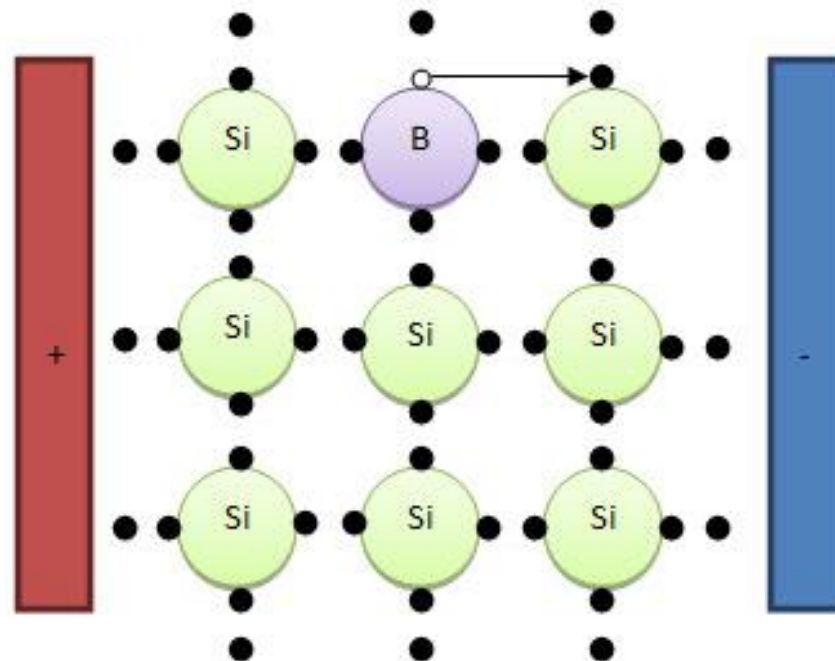
- **Type N:** electron conductivity, dopand has +1 electron
 - **Example:** phosphorus (P) – 5 electrons in the valence layer
 - Phosphorus adds 1 free electron into the crystal structure
 - Negative charge \rightarrow N type semiconductor



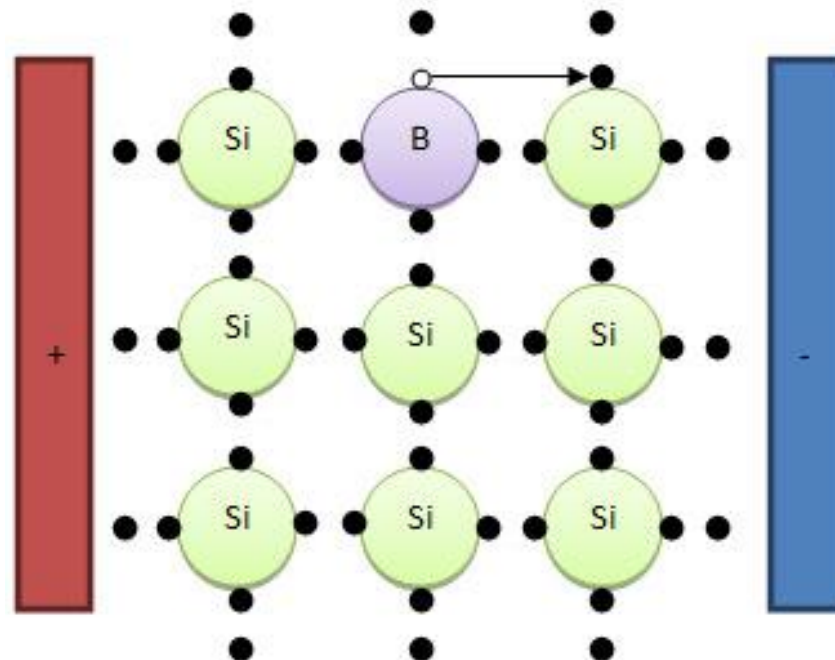
- **Type P:** electron hole conductivity, dopand has -1 electron
 - **Example:** boron (B) – 3 electrons in valence layer



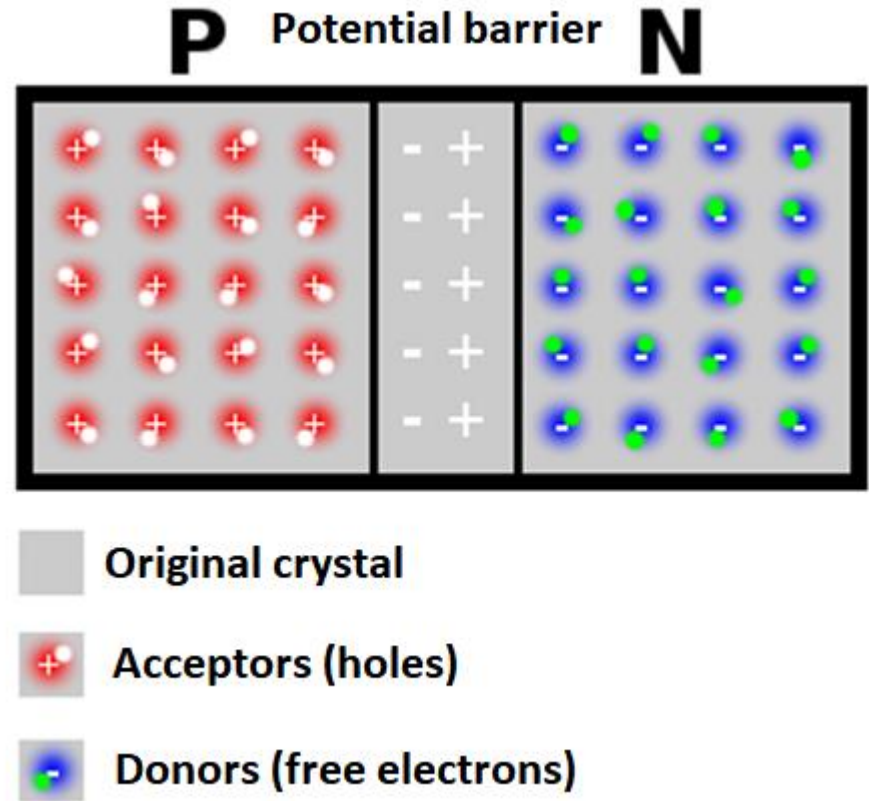
- **Type P:** electron hole conductivity, dopand has -1 electron
 - **Example:** boron (B) – 3 electrons in valence layer
 - The missing electron creates a virtual positively charged particle (“hole”)



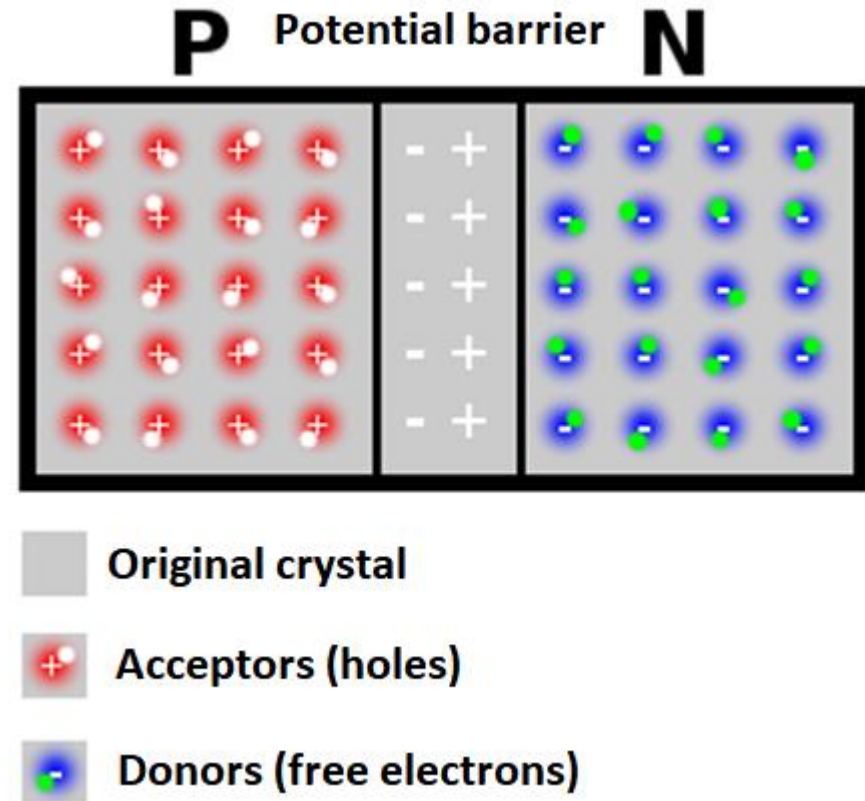
- **Type P:** electron hole conductivity, dopand has -1 electron
 - **Example:** boron (B) – 3 electrons in valence layer
 - The missing electron creates a virtual positively charged particle (“hole”)
 - Positive charge \rightarrow P type semiconductor



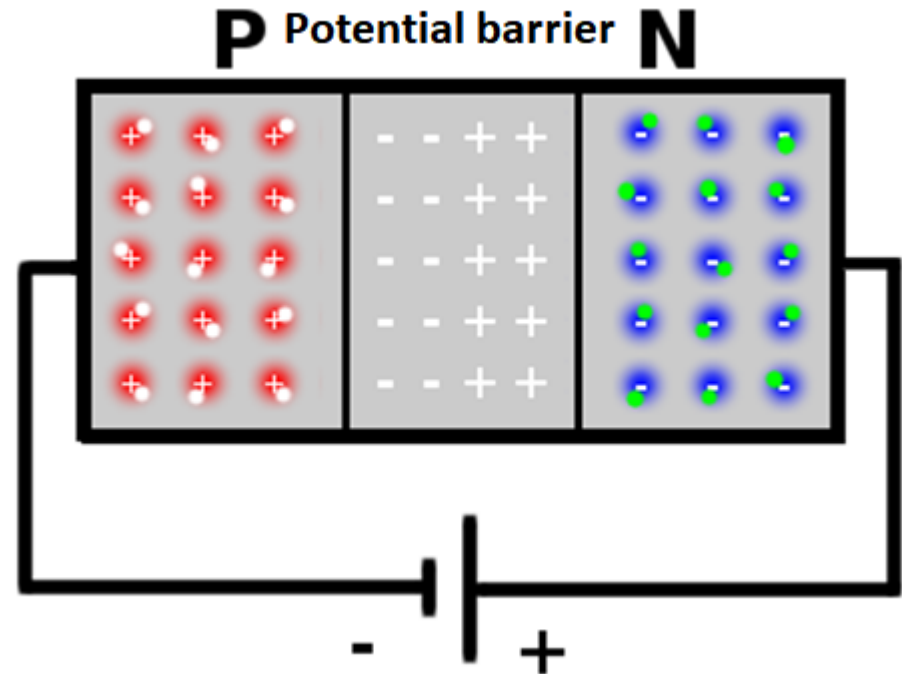
- Junction between P and N semiconductors → **potential barrier**



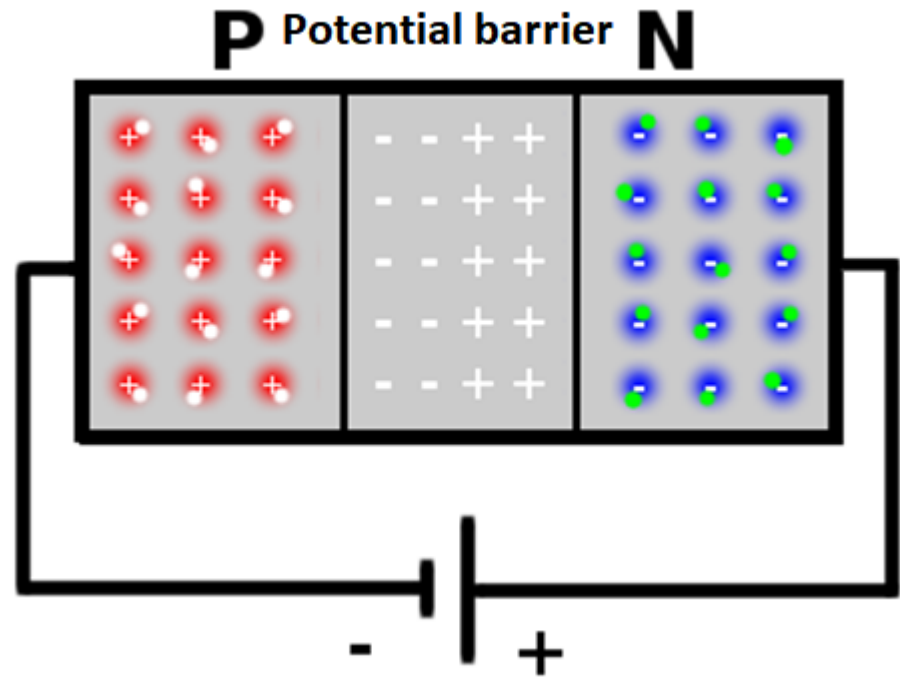
- Junction between P and N semiconductors → **potential barrier**
- Free electrons (-) are attracted to the holes (+)
 - **Recombination** – destruction of the pair (electron randomly meets with a hole, loses part of his energy and fills the hole)



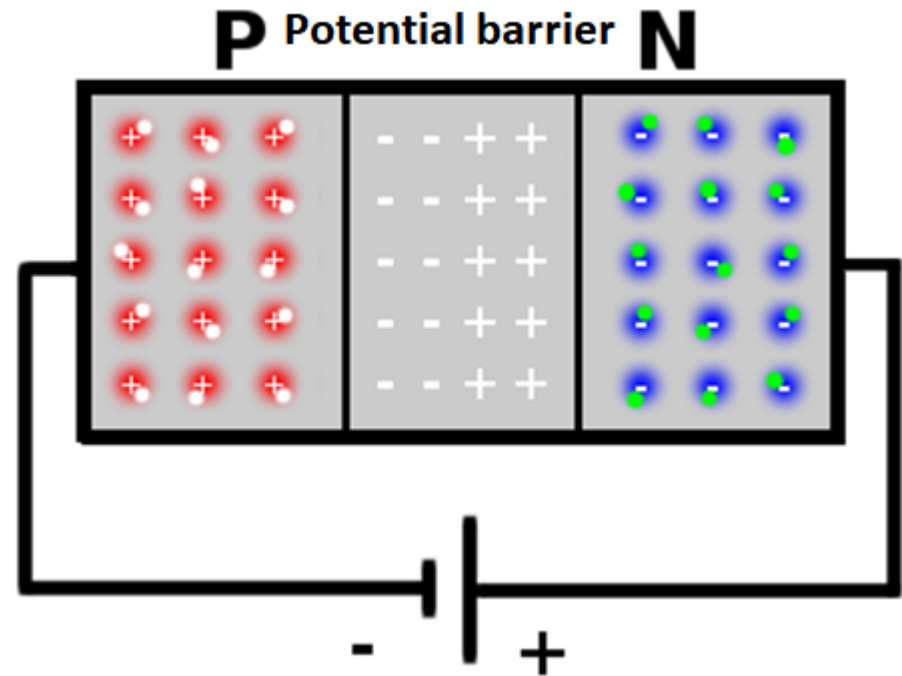
- **Connected voltage source**
- **Positive polarity (+)** of the voltage source **attracts electrons (-)**



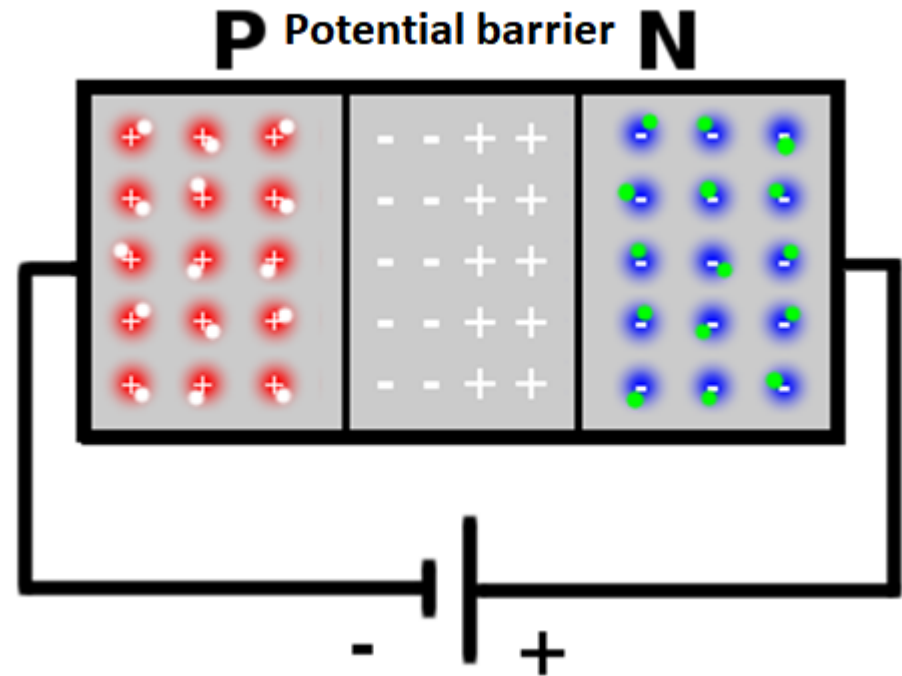
- Connected voltage source



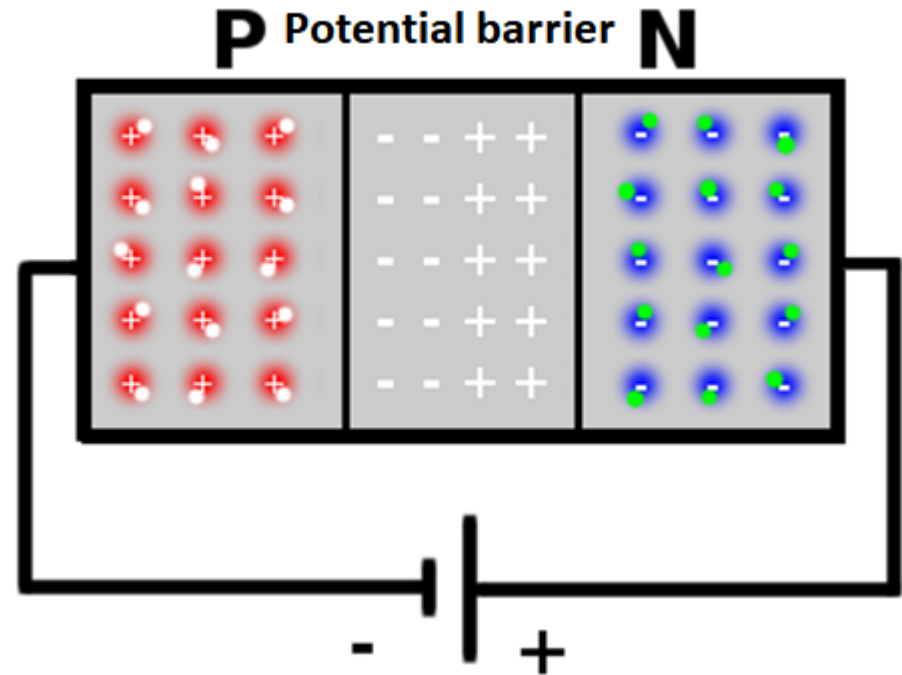
- **Connected voltage source**
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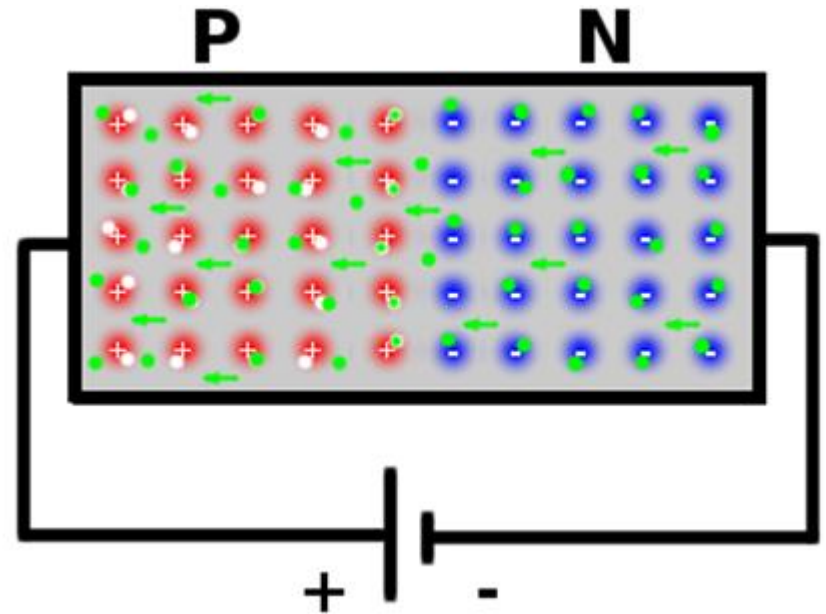
- **Connected voltage source**
- **Positive polarity (+) of the voltage source attracts electrons (-)**
- **Negative polarity (-) of the voltage source attracts holes (+)**



- **Connected voltage source**
- **Positive polarity (+)** of the voltage source **attracts electrons (-)**
- **Negative polarity (-)** of the voltage source **attracts holes (+)**
- **Larger potential barrier, almost no current**

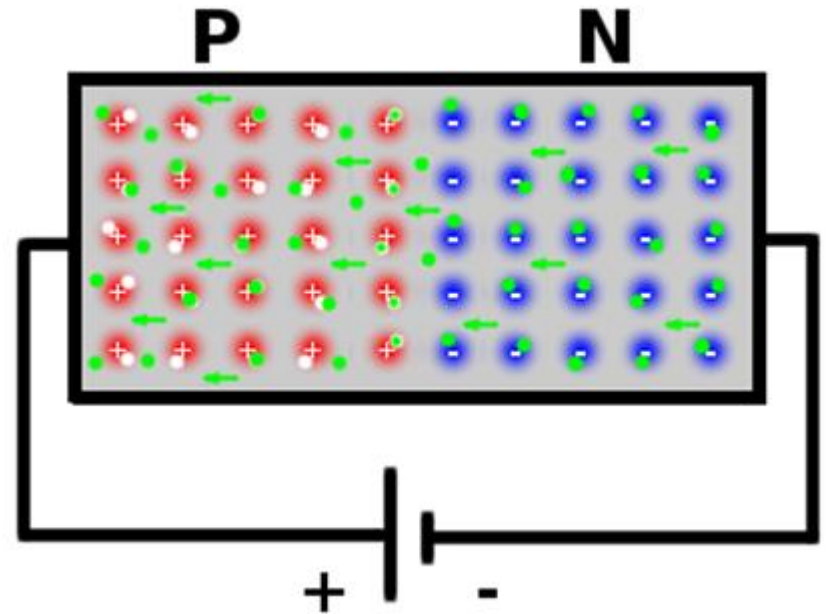


- Connected external voltage source



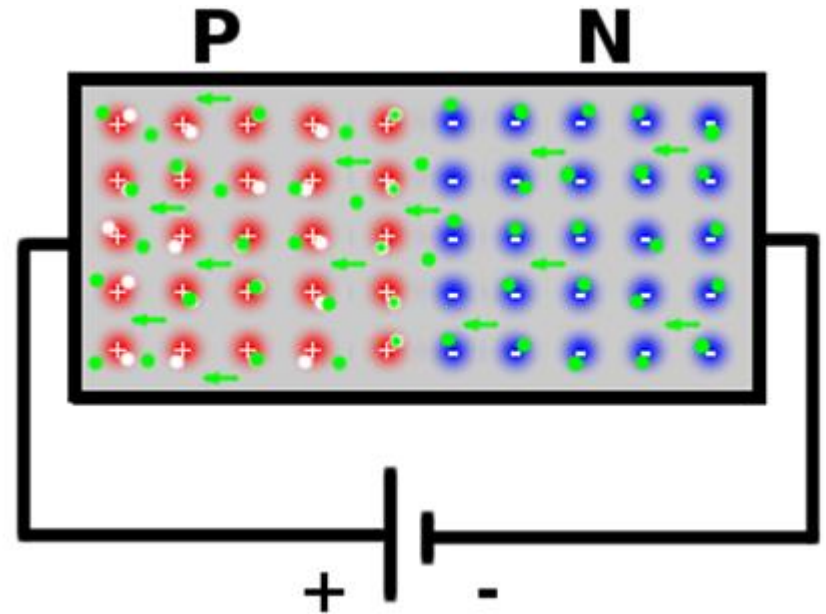
Recombination of holes and electrons

- Connected external voltage source
- **Positive polarity (+)** of the voltage source **repels the holes (+)**



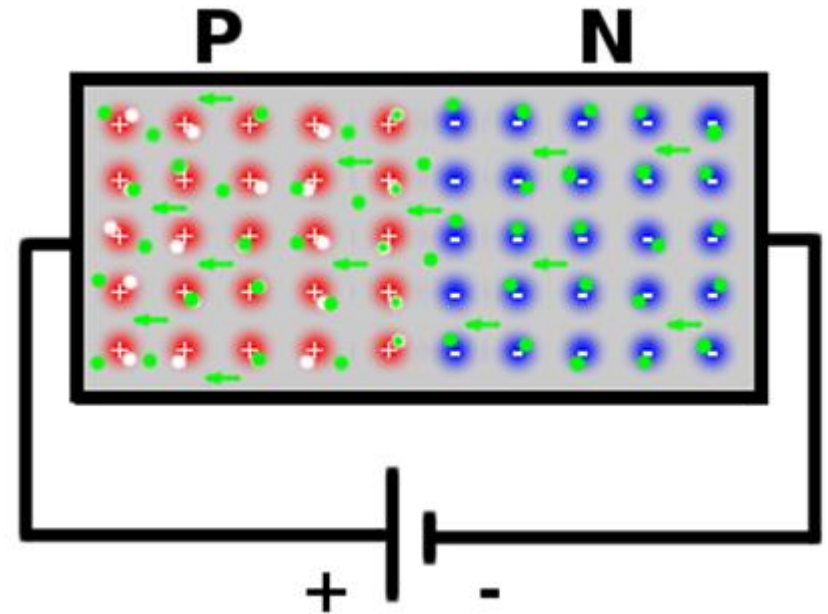
Recombination of holes and electrons

- Connected external voltage source
- **Positive polarity (+)** of the voltage source **repels the holes (+)**
- **Negative polarity (-)** of the voltage source **repels the electrons (-)**



Recombination of holes and electrons

- Connected external voltage source
- **Positive polarity (+)** of the voltage source **repels the holes (+)**
- **Negative polarity (-)** of the voltage source **repels the electrons (-)**
- **Potential barrier shrinks, current flows**



Recombination of holes and electrons

- Analytical solution

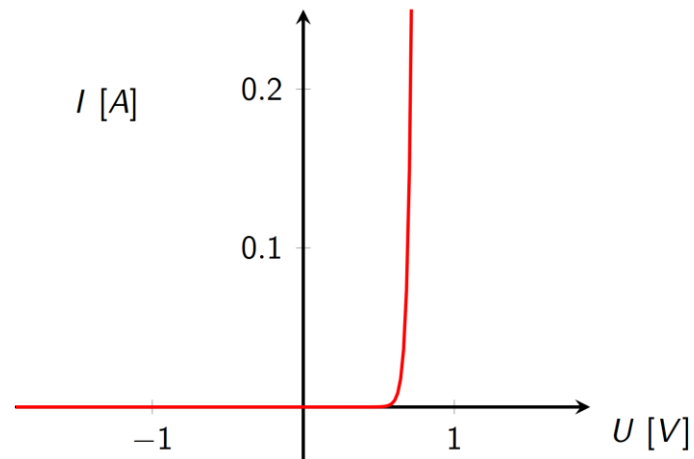
$$I = I_0 \left(e^{\frac{eU}{kT}} - 1 \right)$$

where:

e charge of a electron ($1.6 \times 10^{-19} C$),

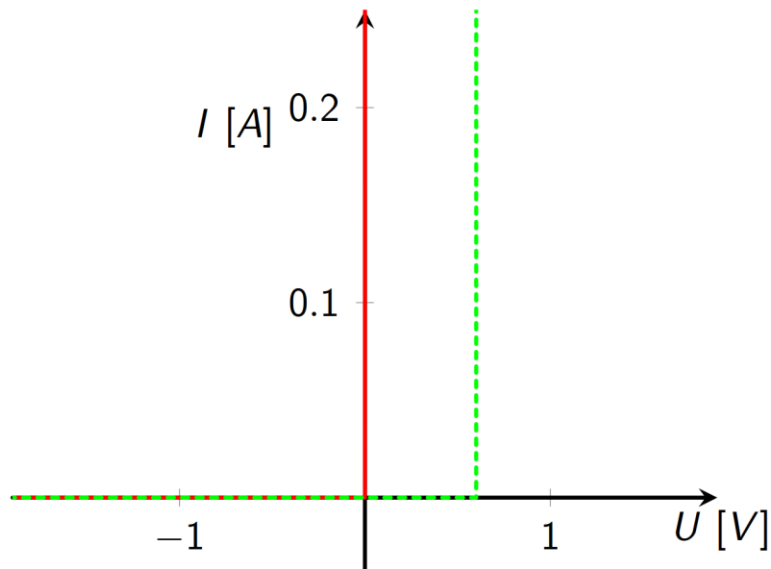
k Boltzmann constant ($1.38 \times 10^{-23} JK^{-1}$),

T temperature of the PN junction ($300K$)

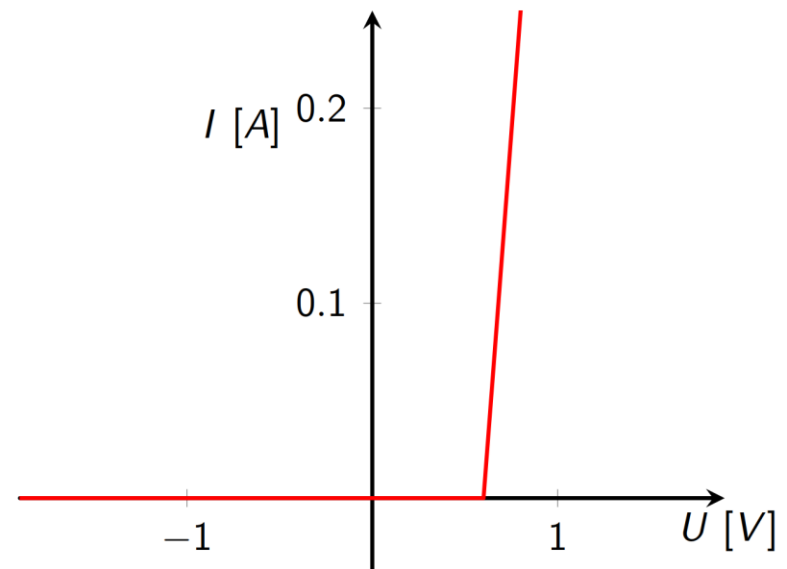


- We can approximate the analytical solution

model1: **switch**; model2: **0.7V+switch**



model3: **0.6V+ R_d +switch**



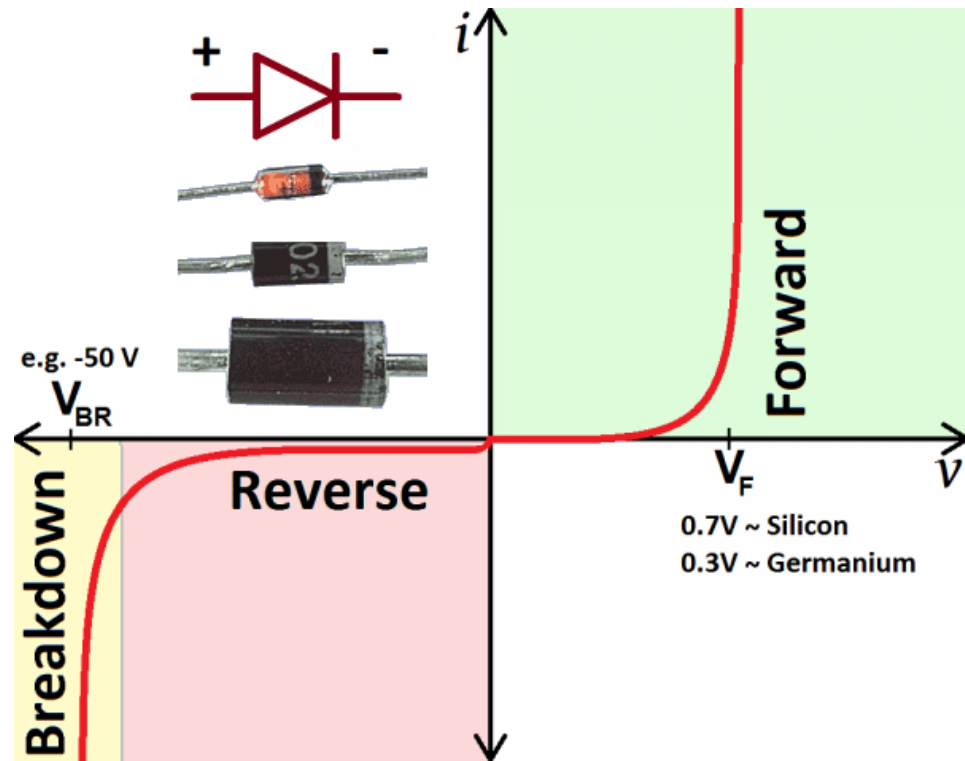
- Diode:

Symbol: (anode=P, cathode=N)



- Packaged **PN junction**
- Two electrodes
 - Positive: **anode, P**
 - Negative: **cathode, N**

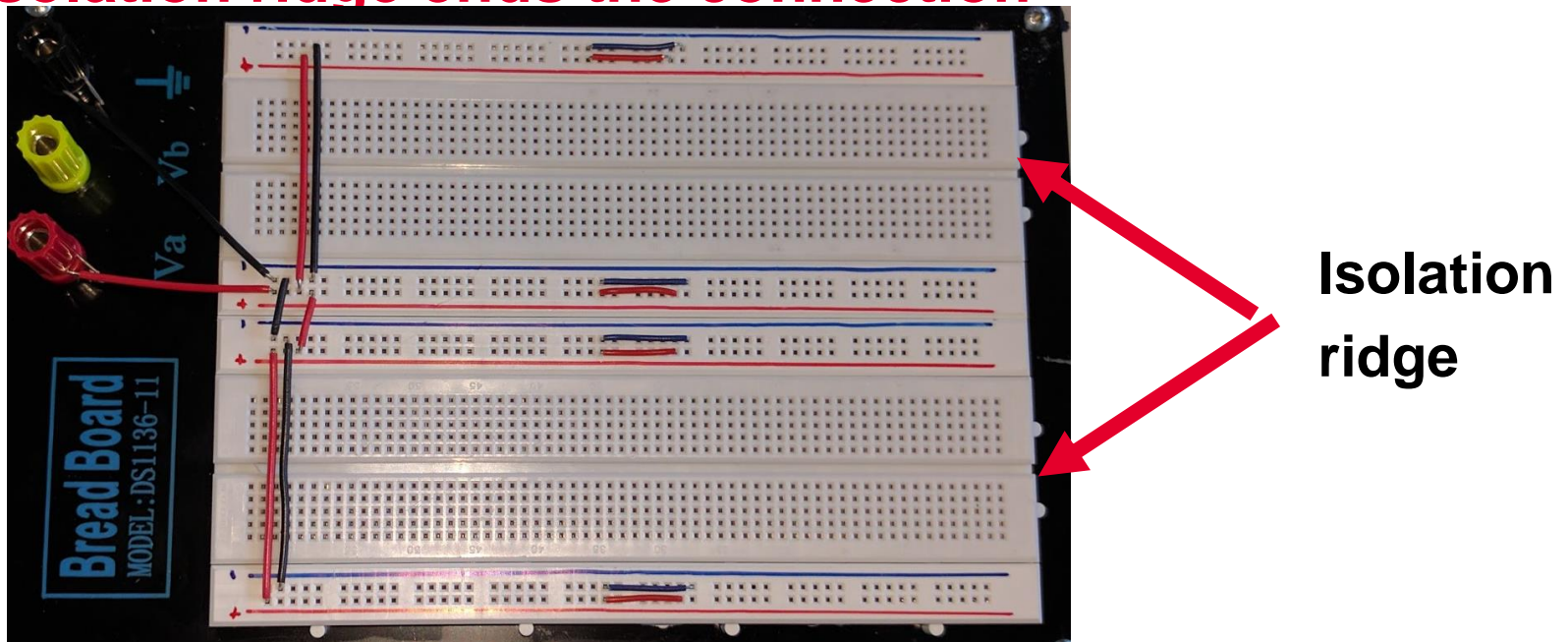
- Real characteristic of the diode:



- Current flows even if the diode is connected in reverse. If the reverse current exceeds the maximum allowed value
 - Destructive breakdown of the diode and its destruction (exception – **Zener diode**)

EQUIPMENT

- You will connect the parts using the solderless board and measure the voltages (or currents) using the multimeter
- Solderless board – **columns are conductively connected**
 - **Isolation ridge ends the connection**



Set before the measurement



DCV
direct voltage

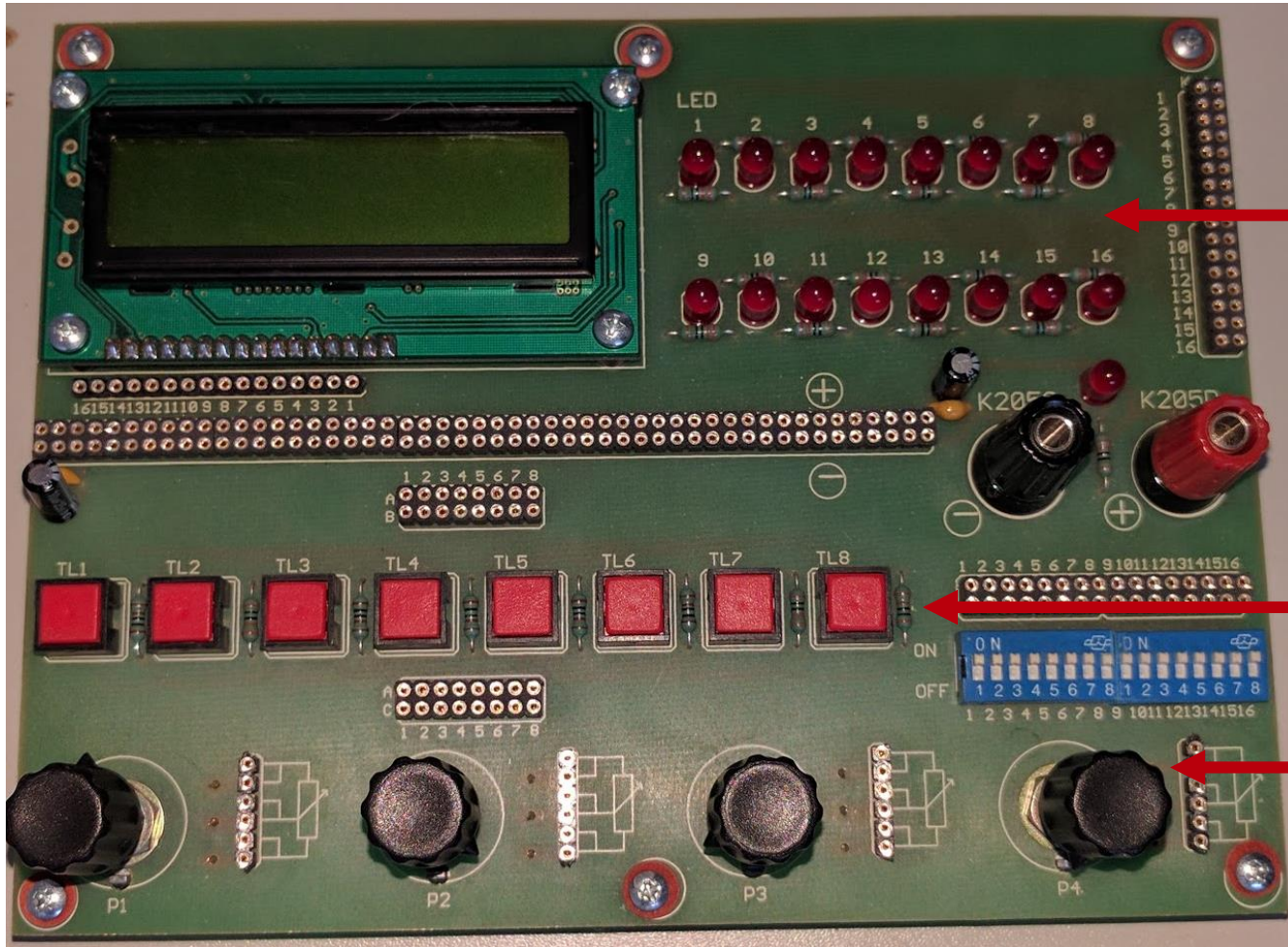
DCA
direct current

Ω
resistanc

Test wire

Ground (GND)

Measure (U, I, R)



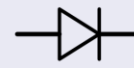
LED diodes

Switches

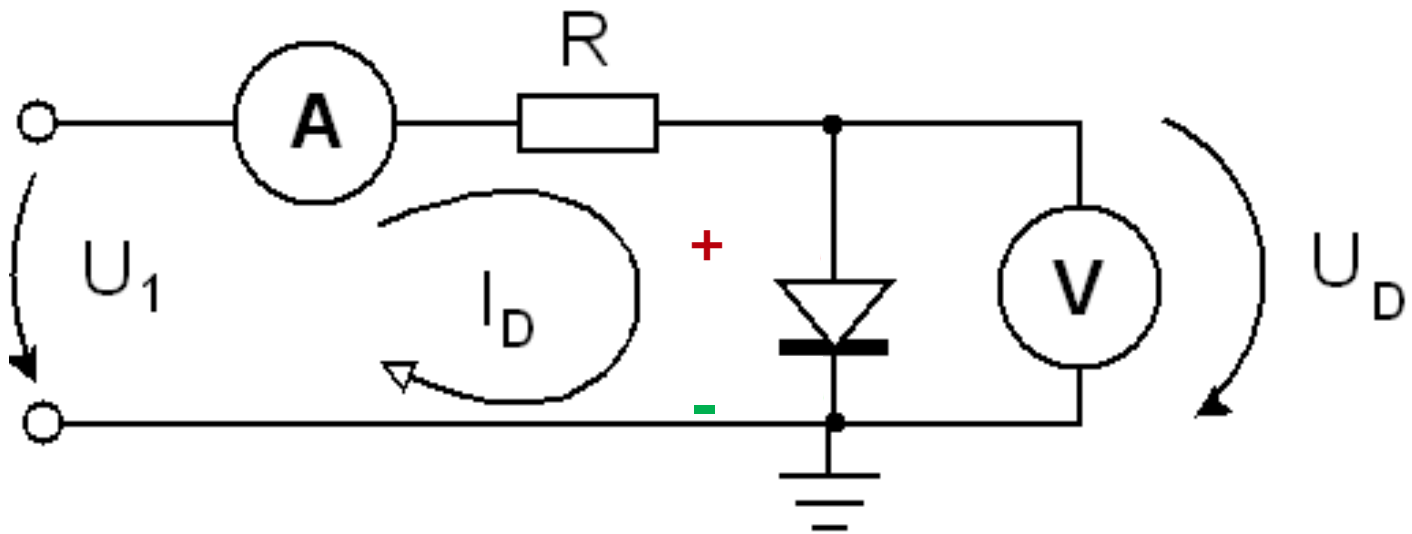
Variable resistors

red **black**

Symbol: (anode=P, cathode=N)

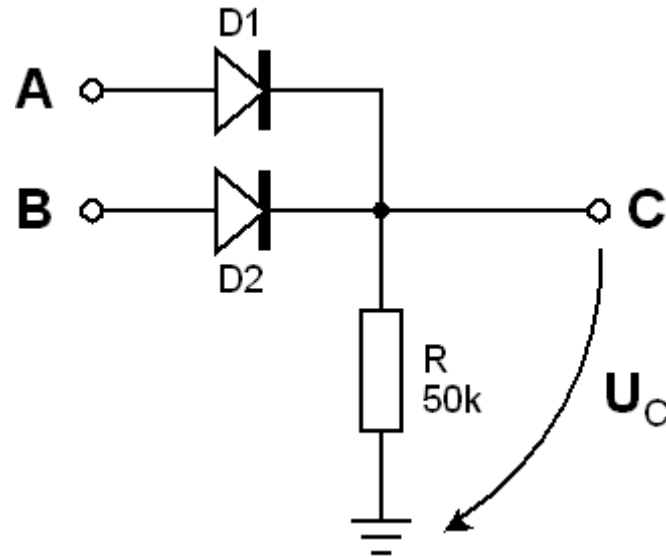


V-A CHARACTERISTIC OF DIODE



LOGICAL OPERATION IN DIODE LOGIC

- Check, if the the following circuit is realizing the logical operation **OR** (addition)



Addition (OR)

- Voltage** in points **A**, **B** are inputs, **C** is the output (inputs are either 0V or 5V)
- Logical 0 in range **0 – 1 V**, logical 1 in range **3 – 5V**

Thank you for your attention!